

Search Notes



Application/Control No.

10/510,241

Examiner

Tan Le

Applicant(s)/Patent under Reexamination

JANG, YOU-SEOK

Art Unit

3632

SEARCHED

Class	Subclass	Date	Examiner
248	118	3/17/06	RL
	118.1		
	118.3		
	917		
	918		
	919		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East T&P Search	3/17/06	RL
IPC Search		